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Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	60MHz
Connectivity	CANbus, Ethernet, I ² C, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	80
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	32K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	121-LBGA
Supplier Device Package	121-MAPBGA (12x12)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mcf52234cvm60

1 MCF52235 Family Configurations

Table 1. MCF52235 Family Configurations

Module	52230	52231	52232	52233	52234	52235	52236
Version 2 ColdFire Core with EMAC (Enhanced Multiply-Accumulate Unit)	•	•	•	•	•	•	•
System Clock (MHz)	60	60	50	60	60	60	50
Performance (Dhrystone 2.1 MIPS)	56	56	46	56	56	56	46
Flash / Static RAM (SRAM)	128/32 Kbytes	128/32 Kbytes	128/32 Kbytes	256/32 Kbytes	256/32 Kbytes	256/32 Kbytes	256/32 Kbytes
Interrupt Controllers (INTC0/INTC1)	•	•	•	•	•	•	•
Fast Analog-to-Digital Converter (ADC)	•	•	•	•	•	•	•
Random Number Generator and Crypto Acceleration Unit (CAU)	—	—	—	—	—	•	—
FlexCAN 2.0B Module	—	•	—	—	•	•	—
Fast Ethernet Controller (FEC) with on-chip interface (EPHY)	•	•	•	•	•	•	•
Four-channel Direct-Memory Access (DMA)	•	•	•	•	•	•	•
Software Watchdog Timer (WDT)	•	•	•	•	•	•	•
Programmable Interrupt Timer	2	2	2	2	2	2	2
Four-Channel General Purpose Timer	•	•	•	•	•	•	•
32-bit DMA Timers	4	4	4	4	4	4	4
QSPI	•	•	•	•	•	•	•
UART(s)	3	3	3	3	3	3	3
I ² C	•	•	•	•	•	•	•
Eight/Four-channel 8/16-bit PWM Timer	•	•	•	•	•	•	•
General Purpose I/O Module (GPIO)	•	•	•	•	•	•	•
Chip Configuration and Reset Controller Module	•	•	•	•	•	•	•
Background Debug Mode (BDM)	•	•	•	•	•	•	•
JTAG - IEEE 1149.1 Test Access Port ¹	•	•	•	•	•	•	•
Package	80 LQFP 112 LQFP	80 LQFP 112 LQFP	80 LQFP	80 LQFP 112 LQFP	112 LQFP 121 MAPBGA	112 LQFP 121 MAPBGA	80 LQFP

¹ The full debug/trace interface is available only on the 112- and 121-pin packages. A reduced debug interface is bonded on the 80-pin package.

1.2.1 Feature Overview

The MCF52235 family includes the following features:

- Version 2 ColdFire variable-length RISC processor core
 - Static operation
 - 32-bit address and data paths on-chip
 - Up to 60 MHz processor core frequency
 - Sixteen general-purpose, 32-bit data and address registers
 - Implements ColdFire ISA_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA_A+)
 - Enhanced Multiply-Accumulate (EMAC) unit with 32-bit accumulator to support $16 \times 16 \rightarrow 32$ or $32 \times 32 \rightarrow 32$ operations
 - Cryptography Acceleration Unit (CAU)
 - Tightly-coupled coprocessor to accelerate software-based encryption and message digest functions
 - FIPS-140 compliant random number generator
 - Support for DES, 3DES, AES, MD5, and SHA-1 algorithms
 - Illegal instruction decode that allows for 68K emulation support
- System debug support
 - Real time trace for determining dynamic execution path
 - Background debug mode (BDM) for in-circuit debugging (DEBUG_B+)
 - Real time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) that can be configured into a 1- or 2-level trigger
- On-chip memories
 - Up to 32 Kbytes of dual-ported SRAM on CPU internal bus, supporting core and DMA access with standby power supply support
 - Up to 256 Kbytes of interleaved Flash memory supporting 2-1-1-1 accesses
- Power management
 - Fully static operation with processor sleep and whole chip stop modes
 - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
 - Clock enable/disable for each peripheral when not used
- Fast Ethernet Controller (FEC)
 - 10/100 BaseT/TX capability, half duplex or full duplex
 - On-chip transmit and receive FIFOs
 - Built-in dedicated DMA controller
 - Memory-based flexible descriptor rings
- On-chip Ethernet Transceiver (EPHY)
 - Digital adaptive equalization
 - Supports auto-negotiation
 - Baseline wander correction
 - Full-/Half-duplex support in all modes
 - Loopback modes
 - Supports MDIO preamble suppression
 - Jumbo packet
- FlexCAN 2.0B module

- Based on and includes all existing features of the Freescale TouCAN module
- Full implementation of the CAN protocol specification version 2.0B
 - Standard Data and Remote Frames (up to 109 bits long)
 - Extended Data and Remote Frames (up to 127 bits long)
 - 0–8 bytes data length
 - Programmable bit rate up to 1 Mbit/sec
- Flexible Message Buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
- Unused Message Buffer space can be used as general purpose RAM space
- Listen only mode capability
- Content-related addressing
- No read/write semaphores required
- Three programmable mask registers: global for MBs 0-13, special for MB14, and special for MB15
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
 - 16-bit divider for clock generation
 - Interrupt control logic with maskable interrupts
 - DMA support
 - Data formats can be 5, 6, 7 or 8 bits with even, odd or no parity
 - Up to 2 stop bits in 1/16 increments
 - Error-detection capabilities
 - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
 - Transmit and receive FIFO buffers
- I²C module
 - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
 - Fully compatible with industry-standard I²C bus
 - Master and slave modes support multiple masters
 - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
 - Full-duplex, three-wire synchronous transfers
 - Up to four chip selects available
 - Master mode operation only
 - Programmable bit rates up to half the CPU clock frequency
 - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
 - Eight analog input channels
 - 12-bit resolution
 - Minimum 1.125 μ s conversion time
 - Simultaneous sampling of two channels for motor control applications
 - Single-scan or continuous operation
 - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit
 - Unused analog channels can be used as digital I/O

- Unique vector number for each interrupt source
- Ability to mask any individual interrupt source or all interrupt sources (global mask-all)
- Support for hardware and software interrupt acknowledge (IACK) cycles
- Combinatorial path to provide wake-up from low power modes
- DMA controller
 - Four fully programmable channels
 - Dual-address transfer support with 8-, 16-, and 32-bit data capability, along with support for 16-byte (4 x 32-bit) burst transfers
 - Source/destination address pointers that can increment or remain constant
 - 24-bit byte transfer counter per channel
 - Auto-alignment transfers supported for efficient block movement
 - Bursting and cycle steal support
 - Software-programmable DMA requesters for the UARTs (3) and 32-bit timers (4)
- Reset
 - Separate reset in and reset out signals
 - Seven sources of reset:
 - Power-on reset (POR)
 - External
 - Software
 - Watchdog
 - Loss of clock
 - Loss of lock
 - Low-voltage detection (LVD)
 - Status flag indication of source of last reset
- Chip integration module (CIM)
 - System configuration during reset
 - Selects one of three clock modes
 - Configures output pad drive strength
 - Unique part identification number and part revision number
- General purpose I/O interface
 - Up to 56 bits of general purpose I/O
 - Bit manipulation supported via set/clear functions
 - Programmable drive strengths
 - Unused peripheral pins may be used as extra GPIO
- JTAG support for system level board testing

1.2.2 V2 Core Overview

The version 2 ColdFire processor core is comprised of two separate pipelines decoupled by an instruction buffer. The two-stage instruction fetch pipeline (IFP) is responsible for instruction-address generation and instruction fetch. The instruction buffer is a first-in-first-out (FIFO) buffer that holds prefetched instructions awaiting execution in the operand execution pipeline (OEP). The OEP includes two pipeline stages. The first stage decodes instructions and selects operands (DSOC); the second stage (AGEX) performs instruction execution and calculates operand effective addresses, if needed.

The V2 core implements the ColdFire instruction set architecture revision A+ with added support for a separate user stack pointer register and four new instructions to assist in bit processing. Additionally, the MCF52235 core includes the enhanced multiply-accumulate (EMAC) unit for improved signal processing capabilities. The EMAC implements a three-stage arithmetic

1.2.24 Package Pinouts

Figure 2 shows the pinout configuration for the 80-pin LQFP.

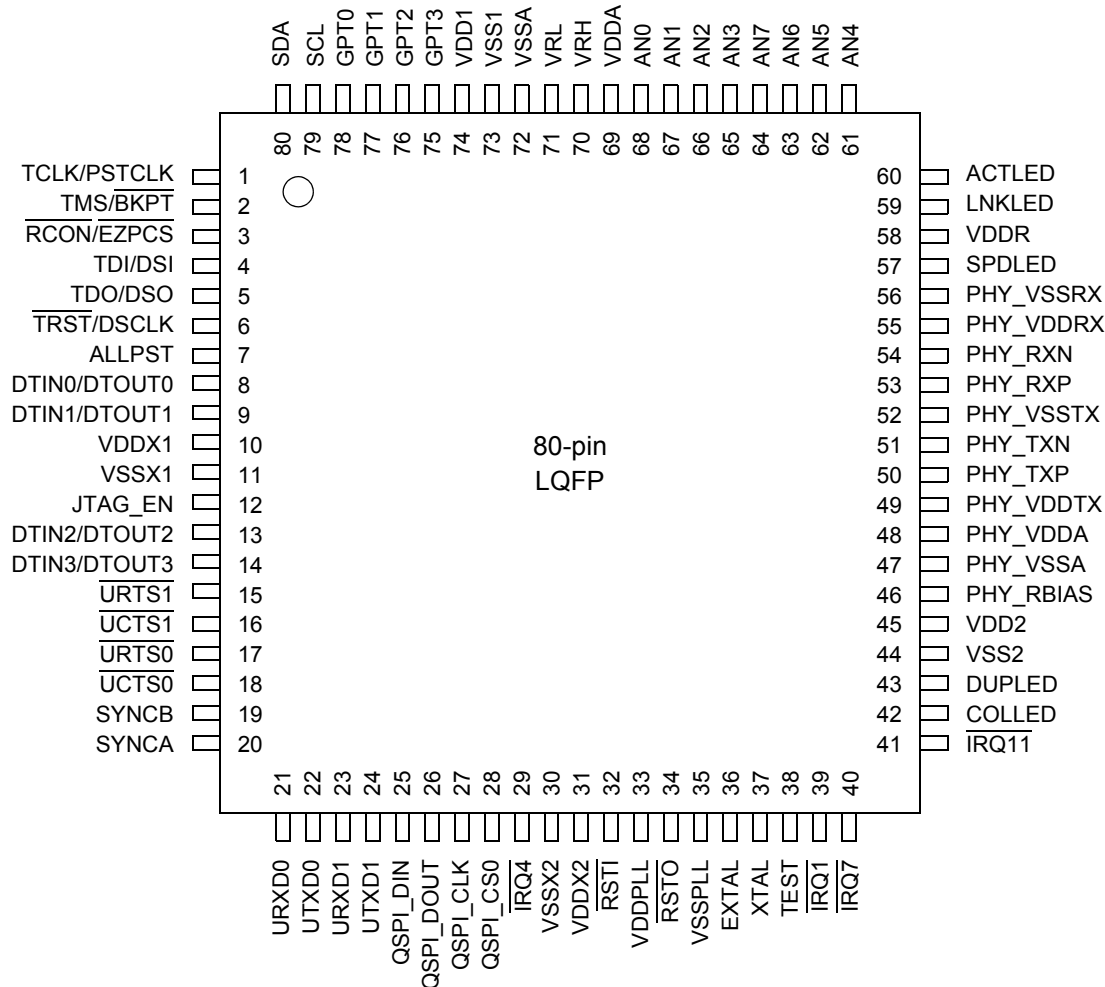


Figure 2. 80-pin LQFP Pin Assignments

Figure 3 shows the pinout configuration for the 112-pin LQFP.

	1	2	3	4	5	6	7	8	9	10	11
A	TCLK	SDA	SCL	$\overline{\text{IRQ15}}$	$\overline{\text{IRQ14}}$	$\overline{\text{IRQ13}}$	VSSA	VDDA	AN1	AN7	AN5
B	TMS	$\overline{\text{RCON}}$	GPT0	GPT3	PWM5	PWM1	VRL	VRH	AN2	AN6	AN4
C	$\overline{\text{TRST}}$	TDO	TDI	GPT2	PWM7	PWM3	$\overline{\text{IRQ12}}$	AN0	AN3	LNKLED	ACTLED
D	DTIN1	DTIN0	ALLPST	GPT1	VDDX	VDDX	VDD	VDDR	PST2	PST3	SPDLED
E	DDATA3	$\overline{\text{IRQ9}}$	$\overline{\text{IRQ8}}$	VSS	VSS	VDDX	VSS	VDD	PST0	PST1	PHY_RXN
F	DDATA0	DDATA1	DDATA2	VSS	VSS	VSS	VSS	VSS	PHY_VSSRX	PHY_VDDR	PHY_RXP
G	DTIN2	$\overline{\text{IRQ5}}$	$\overline{\text{IRQ6}}$	JTAG_EN	VDDX	VDDX	VDDX	PHY_VSSA	PHY_VSSTX	PHY_VDDTX	PHY_TXP
H	DTIN3	$\overline{\text{URTS0}}$	$\overline{\text{URTS1}}$	QSPI_DIN	QSPI_CS1	VDDX	TEST	TXLED	RXLED	PHY_VDDA	PHY_TXN
J	SYNCB	$\overline{\text{UCTS0}}$	$\overline{\text{UCTS1}}$	QSPI_DOUT	QSPI_CS2	$\overline{\text{RSTI}}$	XTAL	$\overline{\text{IRQ1}}$	COLLED	DUPLED	PHY_RBIAS
K	SYNCA	URXD0	URXD1	QSPI_CLK	QSPI_CS3	VDDPLL	VSSPLL	$\overline{\text{IRQ2}}$	$\overline{\text{IRQ11}}$	$\overline{\text{URTS2}}$	URXD2
L	$\overline{\text{IRQ10}}$	UTXD0	UTXD1	QSPI_CS0	$\overline{\text{IRQ4}}$	$\overline{\text{RSTO}}$	EXTAL	$\overline{\text{IRQ3}}$	$\overline{\text{IRQ7}}$	$\overline{\text{UCTS2}}$	UTXD2

Figure 4. 121 MAPBGA Pin Assignments

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
Ethernet LEDs	ACTLED	—	—	PLD[0]	PDSR[32]	PWOR[8]	—	C11	84	60
	COLLED	—	—	PLD[4]	PDSR[36]	PWOR[12]	—	J9	58	42
	DUPLED	—	—	PLD[3]	PDSR[35]	PWOR[11]	—	J10	59	43
	LNKLED	—	—	PLD[1]	PDSR[33]	PWOR[9]	—	C10	83	59
	SPDLED	—	—	PLD[2]	PDSR[34]	PWOR[10]	—	D11	81	57
	RXLED	—	—	PLD[5]	PDSR[37]	PWOR[13]	—	H9	52	—
	TXLED	—	—	PLD[6]	PDSR[38]	PWOR[14]	—	H8	51	—
	VDDR	—	—	—	—	—	—	D8	82	58
Ethernet PHY	PHY_RBIAS	—	—	—	—	—		J11	66	46
	PHY_RXN	—	—	—	—	—		E11	74	54
	PHY_RXP	—	—	—	—	—		F11	73	53
	PHY_TXN	—	—	—	—	—		H11	71	51
	PHY_TXP	—	—	—	—	—		G11	70	50
	PHY_VDDA ⁵	—	—	—		N/A		H10	68	48
	PHY_VDDRX ⁵	—	—	—		N/A		F10	75	55
	PHY_VDDTX ⁵	—	—	—		N/A		G10	69	49
	PHY_VSSA	—	—	—		N/A		G8	67	47
	PHY_VSSRX	—	—	—		N/A		F9	76	56
	PHY_VSSTX	—	—	—		N/A		G9	72	52
I ² C	SCL	CANTX ⁴	UTXD2	PAS[0]	PDSR[0]	—	Pull-Up ⁶	A3	111	79
	SDA	CANRX ⁴	URXD2	PAS[1]	PDSR[0]	—	Pull-Up ⁶	A2	112	80
Interrupts ³	IRQ15	—	—	PGP[7]	PSDR[47]	—	Pull-Up ⁶	A4	106	—
	IRQ14	—	—	PGP[6]	PSDR[46]	—	Pull-Up ⁶	A5	105	—
	IRQ13	—	—	PGP[5]	PSDR[45]	—	Pull-Up ⁶	A6	98	—
	IRQ12	—	—	PGP[4]	PSDR[44]	—	Pull-Up ⁶	C7	97	—

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
Continued Interrupts ³	IRQ11	—	—	PGP[3]	PSDR[43]	—	Pull-Up ⁶	K9	57	41
	IRQ10	—	—	PGP[2]	PSDR[42]	—	Pull-Up ⁶	L1	29	—
	IRQ9	—	—	PGP[1]	PSDR[41]	—	Pull-Up ⁶	E2	11	—
	IRQ8	—	—	PGP[0]	PSDR[40]	—	Pull-Up	E3	10	—
	IRQ7	—	—	PNQ[7]	Low	—	Pull-Up ⁶	L9	56	40
	IRQ6	—	FEC_RXER	PNQ[6]	Low	—	Pull-Up ⁶	G3	19	—
	IRQ5	—	FEC_RXD[1]	PNQ[5]	Low	—	Pull-Up ⁶	G2	20	—
	IRQ4	—	—	PNQ[4]	Low	—	Pull-Up ⁶	L5	41	29
	IRQ3	—	FEC_RXD[2]	PNQ[3]	Low	—	Pull-Up ⁶	L8	53	—
	IRQ2	—	FEC_RXD[3]	PNQ[2]	Low	—	Pull-Up ⁶	K8	54	—
	IRQ1	SYNCA	PWM1	PNQ[1]	High	—	Pull-Up ⁶	J8	55	39
JTAG/BDM	JTAG_EN	—	—	—	N/A	N/A	Pull-Down	G4	18	12
	TCLK/PSTCLK	CLKOUT	—	—	High	—	Pull-Up ⁷	A1	1	1
	TDI/DSI	—	—	—	N/A	N/A	Pull-Up ⁷	C3	4	4
	TDO/DSO	—	—	—	High	N/A	—	C2	5	5
	TMS/BKPT	—	—	—	N/A	N/A	Pull-Up ⁷	B1	2	2
	TRST/DSCLK	—	—	—	N/A	N/A	Pull-Up	C1	6	6
Mode Selection	RCON/EZPCS	—	—	—	N/A	N/A	Pull-Up	B2	3	3
PWM	PWM7	—	—	PTD[3]	PDSR[31]	—	—	C5	104	—
	PWM5	—	—	PTD[2]	PDSR[30]	—	—	B5	103	—
	PWM3	—	—	PTD[1]	PDSR[29]	—	—	C6	100	—
	PWM1	—	—	PTD[0]	PDSR[28]	—	—	B6	99	—

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
UART 1 ³	UCTS1	SYNCA	URXD2	PUB[3]	PDSR[15]	—	—	J3	24	16
	URTS1	SYNCB	UTXD2	PUB[2]	PDSR[14]	—	—	H3	23	15
	URXD1	—	FEC_TXD[0]	PUB[1]	PDSR[13]	PWOR[2]	—	K3	32	23
	UTXD1	—	FEC_COL	PUB[0]	PDSR[12]	PWOR[3]	—	L3	33	24
UART 2	UCTS2	—	—	PUC[3]	PDSR[27]	—	—	L10	61	—
	URTS2	—	—	PUC[2]	PDSR[26]	—	—	K10	60	—
	URXD2	—	—	PUC[1]	PDSR[25]	—	—	K11	62	—
	UTXD2	—	—	PUC[0]	PDSR[24]	—	—	L11	63	—
FlexCAN	SYNCA	CANTX ⁴	FEC_MDIO	PAS[3]	PDSR[39]	—	—	—	28	20
	SYNCB	CANRX ⁴	FEC_MDC	PAS[2]	PDSR[39]	—	—	—	27	19
VDD ^{5,11}	VDD	—	—	—	N/A	N/A	—	D7, E8	65,102	45,74
VDDX	VDDX	—	—	—	N/A	N/A	—	D5, D6, E6, G5, G6, G7, H6	14, 43	10, 31
VSS	VSS	—	—	—	N/A	N/A	—	E4, E5, E7, F4, F5, F6, F7, F8	64,101	44,73
VSSX	VSSX	—	—	—	N/A	N/A	—	—	15, 42	11, 30

¹ The PDSR and PSSR registers are described in [Chapter 14, “General Purpose I/O Module](#). All programmable signals default to 2mA drive in normal (single-chip) mode.

² All signals have a pull-up in GPIO mode.

³ The use of an external PHY limits ADC, interrupt, and QSPI functionality. It also disables the UART0/1 and timer pins.

⁴ The multiplexed CANTX and CANRX signals do not have dedicated pins, but are available as muxed replacements for other signals.

⁵ The VDD1, VDD2, VDDPLL, and PHY_VDD pins are for decoupling only and should not have power directly applied to them.

⁶ For primary and GPIO functions only.

⁷ Only when JTAG mode is enabled.

⁸ For secondary and GPIO functions only.

⁹ RSTI has an internal pull-up resistor; however, the use of an external resistor is strongly recommended.

¹⁰ For GPIO function. Primary Function has pull-up control within the GPT module.

¹¹ This list for power and ground does not include those dedicated power/ground pins included elsewhere, e.g. in the Ethernet PHY.

1.12 ADC Signals

Table 13 describes the signals of the Analog-to-Digital Converter.

Table 13. ADC Signals

Signal Name	Abbreviation	Function	I/O
Analog Inputs	AN[7:0]	Inputs to the A-to-D converter.	I
Analog Reference	V _{RH}	Reference voltage high and low inputs.	I
	V _{RL}		I
Analog Supply	V _{DDA}	Isolate the ADC circuitry from power supply noise	—
	V _{SSA}		—

1.13 General Purpose Timer Signals

Table 14 describes the General Purpose Timer Signals.

Table 14. GPT Signals

Signal Name	Abbreviation	Function	I/O
General Purpose Timer Input/Output	GPT[3:0]	Inputs to or outputs from the general purpose timer module	I/O

1.14 Pulse Width Modulator Signals

Table 15 describes the PWM signals.

Table 15. PWM Signals

Signal Name	Abbreviation	Function	I/O
PWM Output Channels	PWM[7:0]	Pulse width modulated output for PWM channels	O

1.15 Debug Support Signals

These signals are used as the interface to the on-chip JTAG controller and also to interface to the BDM logic.

Table 16. Debug Support Signals

Signal Name	Abbreviation	Function	I/O
JTAG Enable	JTAG_EN	Select between debug module and JTAG signals at reset	I
Test Reset	$\overline{\text{TRST}}$	This active-low signal is used to initialize the JTAG logic asynchronously.	I
Test Clock	TCLK	Used to synchronize the JTAG logic.	I
Test Mode Select	TMS	Used to sequence the JTAG state machine. TMS is sampled on the rising edge of TCLK.	I
Test Data Input	TDI	Serial input for test instructions and data. TDI is sampled on the rising edge of TCLK.	I

2.3 DC Electrical Specifications

Table 22. DC Electrical Specifications ¹

Characteristic	Symbol	Min	Max	Unit
Supply voltage	V_{DD}	3.0	3.6	V
Input high voltage	V_{IH}	$0.7 \times V_{DD}$	4.0	V
Input low voltage	V_{IL}	$V_{SS} - 0.3$	$0.35 \times V_{DD}$	V
Input hysteresis	V_{HYS}	$0.06 \times V_{DD}$	—	mV
Low-voltage detect trip voltage (V_{DD} falling)	V_{LVD}	2.15	2.3	V
Low-voltage detect hysteresis (V_{DD} rising)	V_{LVDHYS}	60	120	mV
Input leakage current $V_{in} = V_{DD}$ or V_{SS} , input-only pins	I_{in}	-1.0	1.0	μA
High impedance (off-state) leakage current $V_{in} = V_{DD}$ or V_{SS} , all input/output and output pins	I_{OZ}	-1.0	1.0	μA
Output high voltage (all input/output and all output pins) $I_{OH} = -2.0$ mA	V_{OH}	$V_{DD} - 0.5$	—	V
Output low voltage (all input/output and all output pins) $I_{OL} = 2.0$ mA	V_{OL}	—	0.5	V
Weak internal pull-up device current, tested at V_{IL} max. ²	I_{APU}	-10	-130	μA
Input capacitance ³ All input-only pins All input/output (three-state) pins	C_{in}	— —	7 7	pF
Load capacitance ⁴ Low drive strength High drive strength	C_L		25 50	pF
DC injection current ^{3, 5, 6, 7} $V_{NEGCLAMP} = V_{SS} - 0.3$ V, $V_{POSCLAMP} = V_{DD} + 0.3$ Single pin limit Total MCU limit, Includes sum of all stressed pins	I_{IC}	-1.0 -10	1.0 10	mA

¹ Refer to Table 25 for additional PLL specifications.

² Refer to Table 3 for pins with internal pull-up devices.

³ This parameter is characterized before qualification rather than 100% tested.

⁴ pF load ratings are based on DC loading and are provided as an indication of driver strength. High speed interfaces require transmission line analysis to determine proper drive strength and termination.

⁵ All functional non-supply pins are internally clamped to V_{SS} and their respective V_{DD} .

⁶ Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

⁷ The power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If positive injection current ($V_{in} > V_{DD}$) is greater than I_{DD} , the injection current may flow out of V_{DD} and could result in external power supply going out of regulation. Ensure that the external V_{DD} load shunts current greater than maximum injection current. This is the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if clock rate is very low which would reduce overall power consumption. Also, the system clock is not present during the power-up sequence until the PLL has attained lock.

Table 23. Active Current Consumption Specifications

Characteristic	Symbol	Typical				Peak	Unit
		Running from SRAM, EPHY Off	Running from Flash, EPHY Off	Running from Flash, EPHY 10BaseT	Running from Flash, EPHY 100BaseT		
Active current, core and I/O PLL @25 MHz PLL @60 MHz	$I_{DDR} + I_{DDX} + I_{DDA}$	75 130	82 138	150 220	260 310	290 340	mA
Analog supply current Normal operation Low-power STOP	I_{DDA}	20 15	20 15	20 15	20 15	30 50	mA μ A

Table 24. Current Consumption Specifications in Low-Power Modes¹

Mode ²	PLL @25 MHz (typical) ³	PLL @60 MHz (typical) ³	PLL @60 MHz (peak) ⁴	Unit
STOP mode 3 (STPMD[1:0]=11)	0.2		1.0	mA
STOP mode 2 (STPMD[1:0]=10)	7		—	
STOP mode 1 (STPMD[1:0]=01)	10	12	—	
STOP mode 0 (STPMD[1:0]=00)	10	12	—	
WAIT	16	27	—	
DOZE	16	27	—	
RUN	25	45	—	

¹ All values are measured with a 3.30 V power supply.

² Refer to the “Power Management” chapter in the *MCF52235 ColdFire® Integrated Microcontroller Reference Manual* for more information on low-power modes.

³ These values were obtained with CLKOUT and all peripheral clocks except for the CFM clock disabled prior to entering low-power mode. The tests were performed at room temperature. All code was executed from flash memory; running code from SRAM further reduces power consumption.

⁴ These values were obtained with CLKOUT and all peripheral clocks enabled. All code was executed from flash memory.

- ⁷ This value has been updated
- ⁸ Load capacitance determined from crystal manufacturer specifications and include circuit board parasitics.
- ⁹ Assuming a reference is available at power up, lock time is measured from the time V_{DD} and V_{DDPLL} are valid to \overline{RSTO} negating. If the crystal oscillator is the reference for the PLL, the crystal start up time must be added to the PLL lock time to determine the total start-up time.
- ¹⁰ Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{sys} . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V_{DDPLL} and V_{SSPLL} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval
- ¹¹ Based on slow system clock of 40 MHz measured at f_{sys} max.

2.5 General Purpose I/O Timing

GPIO can be configured for certain pins of the QSPI, timers, UARTs, FEC, and interrupts. When in GPIO mode, the timing specification for these pins is given in [Table 26](#) and [Figure 6](#).

The GPIO timing is met under the following load test conditions:

- 50 pF / 50 Ω for high drive
- 25 pF / 25 Ω for low drive

Table 26. GPIO Timing

Num	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT high to GPIO output valid	t_{CHPOV}	—	10	ns
G2	CLKOUT high to GPIO output invalid	t_{CHPOI}	1.5	—	ns
G3	GPIO input valid to CLKOUT high	t_{PVCH}	9	—	ns
G4	CLKOUT high to GPIO input invalid	t_{CHPI}	1.5	—	ns

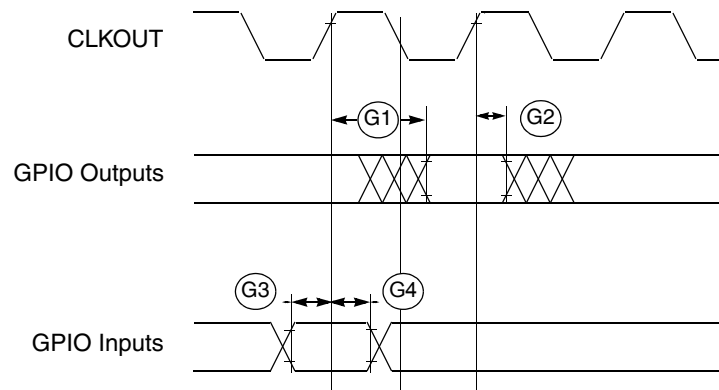


Figure 6. GPIO Timing

2.8 EPHY Parameters

2.8.1 EPHY Timing

Table 30 and Figure 9 show the relevant EPHY timing parameters.

Table 30. EPHY Timing Parameters

Num	Characteristic	Symbol	Value	Unit
E1	EPHY startup time	$t_{\text{Start-Up}}$	360	μs

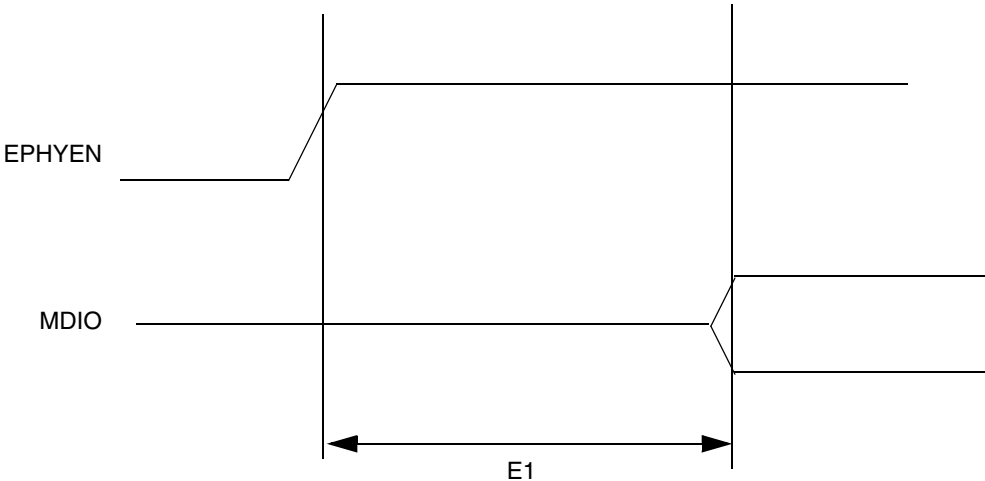


Figure 9. EPHY Timing

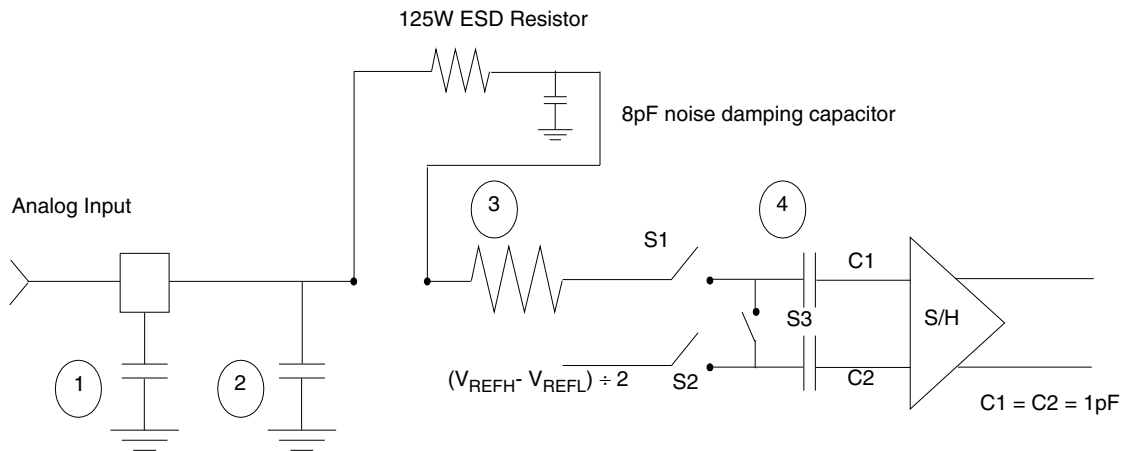
2.8.2 10BASE-T SQE (Heartbeat) Timing

Table 31 and Figure 10 show the relevant 10BASE-T SQE (heartbeat) timing parameters.

Table 31. 10BASE-T SQE (Heartbeat) Timing Parameters

Characteristic	Symbol	Min	Typ ¹	Max	Units
COL (SQE) delay after TXEN off	t1	—	1.0	—	μs
COL (SQE) pulse duration	t2	—	1.0	—	μs

¹ Typical values are at 25°C.



- 1 Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling; 1.8pF
- 2 Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing; 2.04pF
- 3 Equivalent resistance for the channel select mux; 100 ohms
- 4 Sampling capacitor at the sample and hold circuit. Capacitor C1 is normally disconnected from the input and is only connected to it at sampling time; 1.4pF
- 5 Equivalent input impedance, when the input is selected = $\frac{1}{\text{ADC CLOCK RATE} \times (1.4 \times 10^{-12})}$

Figure 12. Equivalent Circuit for A/D Loading

2.10 DMA Timers Timing Specifications

Table 36 lists timer module AC timings.

Table 36. Timer Module AC Timing Specifications

Name	Characteristic ¹	Min	Max	Unit
T1	DTIN0 / DTIN1 / DTIN2 / DTIN3 cycle time	$3 \times t_{CYC}$	—	ns
T2	DTIN0 / DTIN1 / DTIN2 / DTIN3 pulse width	$1 \times t_{CYC}$	—	ns

¹ All timing references to CLKOUT are given to its rising edge.

2.11 EzPort Electrical Specifications

Table 37. EzPort Electrical Specifications

Name	Characteristic	Min	Max	Unit
EP1	EPCK frequency of operation (all commands except READ)	—	$f_{sys} / 2$	MHz
EP1a	EPCK frequency of operation (READ command)	—	$f_{sys} / 8$	MHz
EP2	EPCS_b negation to next EPCS_b assertion	$2 \times T_{cyc}$	—	ns
EP3	EPCS_B input valid to EPCK high (setup)	5	—	ns
EP4	EPCK high to EPCS_B input invalid (hold)	5	—	ns
EP5	EPD input valid to EPCK high (setup)	2	—	ns
EP6	EPCK high to EPD input invalid (hold)	5	—	ns

Table 37. EzPort Electrical Specifications (continued)

Name	Characteristic	Min	Max	Unit
EP7	EPCK low to EPQ output valid (out setup)	—	12	ns
EP8	EPCK low to EPQ output invalid (out hold)	0	—	ns
EP9	EPCS_B negation to EPQ tri-state	—	12	ns

2.12 QSPI Electrical Specifications

Table 38 lists QSPI timings.

Table 38. QSPI Modules AC Timing Specifications

Name	Characteristic	Min	Max	Unit
QS1	QSPI_CS[3:0] to QSPI_CLK	1	510	t _{CYC}
QS2	QSPI_CLK high to QSPI_DOUT valid	—	10	ns
QS3	QSPI_CLK high to QSPI_DOUT invalid (output hold)	2	—	ns
QS4	QSPI_DIN to QSPI_CLK (input setup)	9	—	ns
QS5	QSPI_DIN to QSPI_CLK (input hold)	9	—	ns

The values in Table 38 correspond to Figure 13.

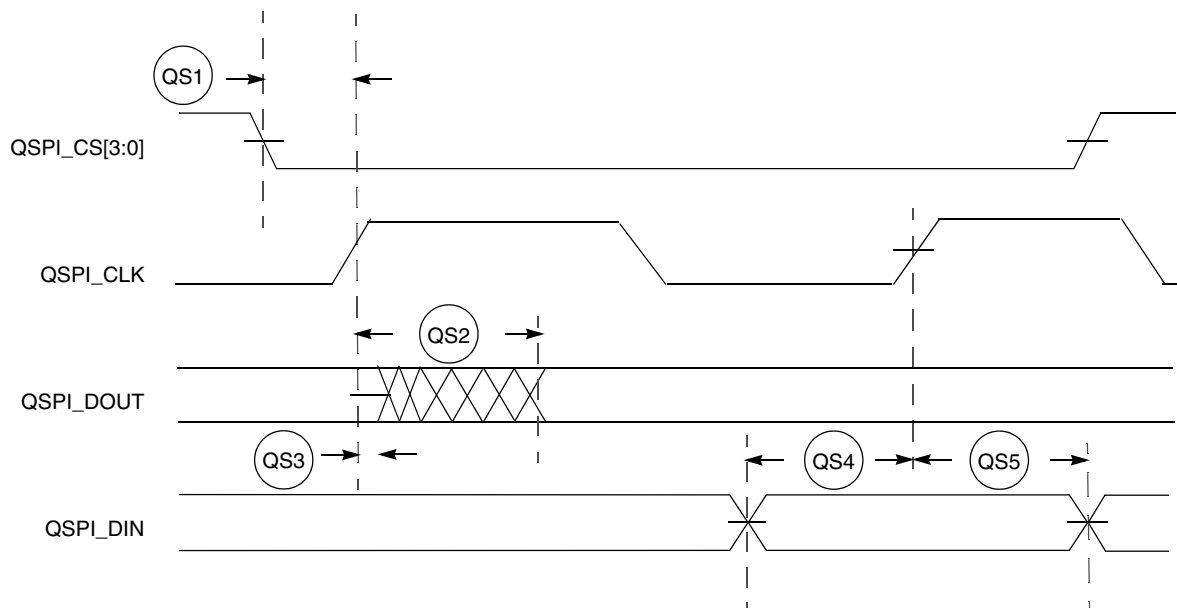


Figure 13. QSPI Timing

2.13 JTAG and Boundary Scan Timing

Table 39. JTAG and Boundary Scan Timing

Num	Characteristics ¹	Symbol	Min	Max	Unit
J1	TCLK frequency of operation	f_{JCYC}	DC	1/4	$f_{sys}/2$
J2	TCLK cycle period	t_{JCYC}	$4 \times t_{CYC}$	—	ns
J3	TCLK clock pulse width	t_{JCW}	26	—	ns
J4	TCLK rise and fall times	t_{JCRF}	0	3	ns
J5	Boundary scan input data setup time to TCLK rise	t_{BSDST}	4	—	ns
J6	Boundary scan input data hold time after TCLK rise	t_{BSDHT}	26	—	ns
J7	TCLK low to boundary scan output data valid	t_{BSDV}	0	33	ns
J8	TCLK low to boundary scan output high Z	t_{BSDZ}	0	33	ns
J9	TMS, TDI input data setup time to TCLK rise	t_{TAPBST}	4	—	ns
J10	TMS, TDI input data hold time after TCLK rise	t_{TAPBHT}	10	—	ns
J11	TCLK low to TDO data valid	t_{TDODV}	0	26	ns
J12	TCLK low to TDO high Z	t_{TDODZ}	0	8	ns
J13	\overline{TRST} assert time	t_{TRSTAT}	100	—	ns
J14	\overline{TRST} setup time (negation) to TCLK high	t_{TRSTST}	10	—	ns

¹ JTAG_EN is expected to be a static signal. Hence, it is not associated with any timing.

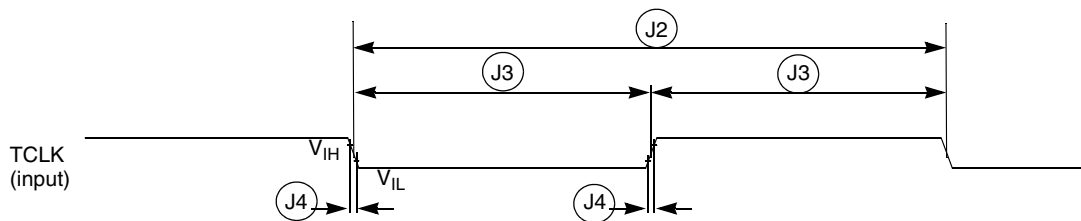


Figure 14. Test Clock Input Timing

2.14 Debug AC Timing Specifications

Table 40 lists specifications for the debug AC timing parameters shown in Figure 19.

Table 40. Debug AC Timing Specification

Num	Characteristic	60 MHz		Units
		Min	Max	
D1	PST, DDATA to CLKOUT setup	4	—	ns
D2	CLKOUT to PST, DDATA hold	1.5	—	ns
D3	DSI-to-DSCLK setup	$1 \times t_{CYC}$	—	ns
D4 ¹	DSCLK-to-DSO hold	$4 \times t_{CYC}$	—	ns
D5	DSCLK cycle time	$5 \times t_{CYC}$	—	ns
D6	\overline{BKPT} input data setup time to CLKOUT Rise	4	—	ns
D7	\overline{BKPT} input data hold time to CLKOUT Rise	1.5	—	ns
D8	CLKOUT high to \overline{BKPT} high Z	0.0	10.0	ns

¹ DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 18 shows real-time trace timing for the values in Table 40.

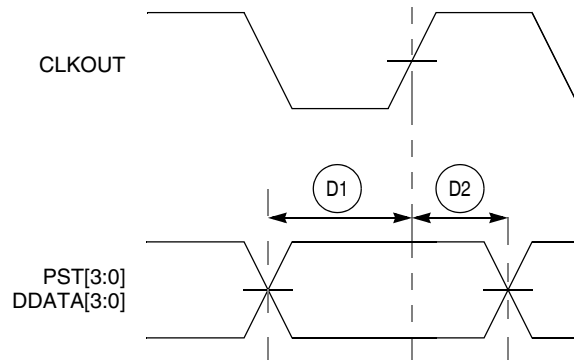


Figure 18. Real-Time Trace AC Timing

Figure 19 shows BDM serial port AC timing for the values in Table 40.

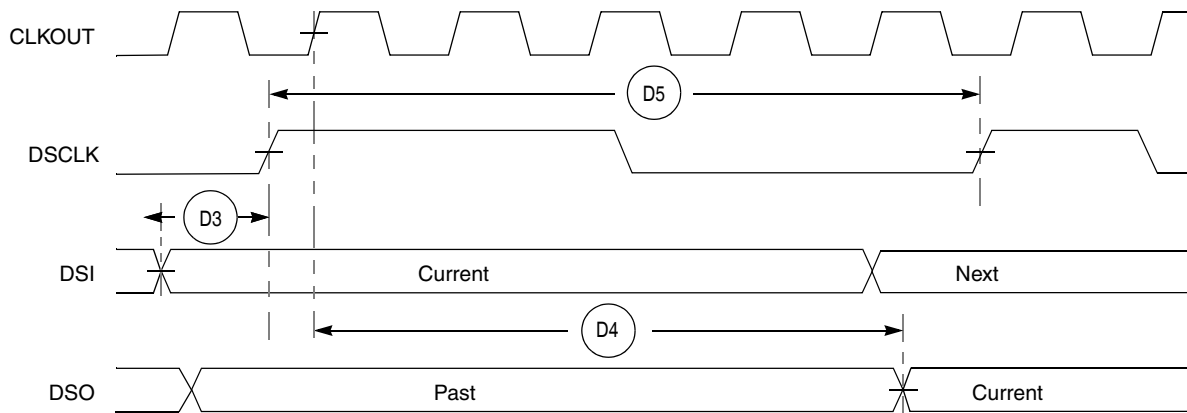
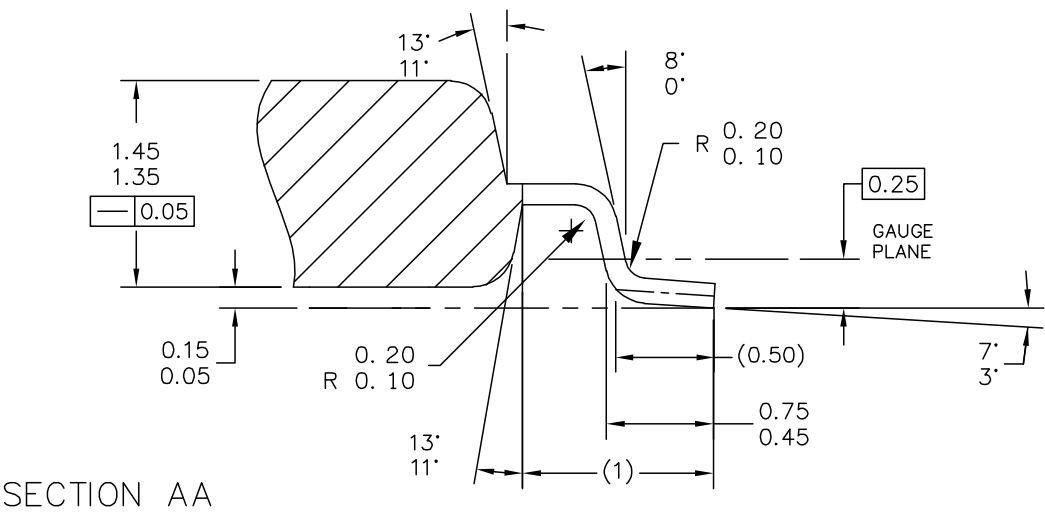
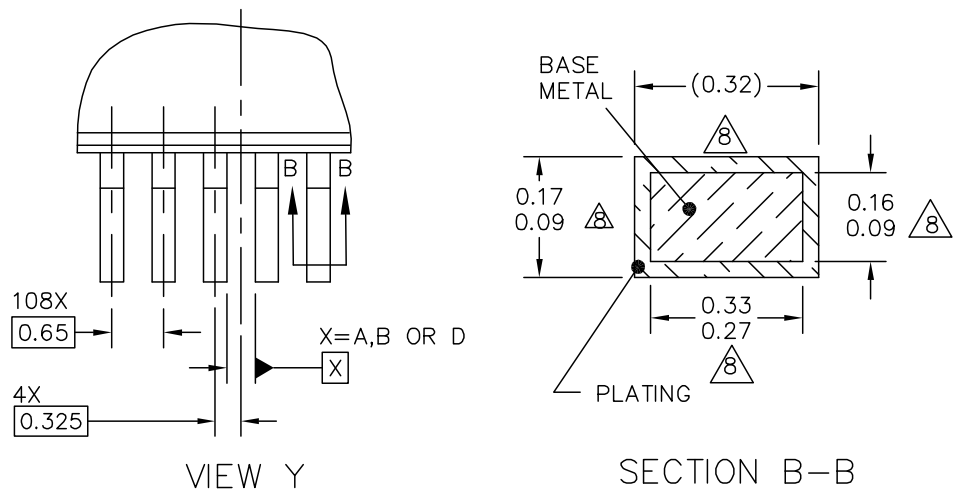


Figure 19. BDM Serial Port AC Timing



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TITLE: 112LD LQFP 20 X 20 X 1.4 0.65 PITCH		DOCUMENT NO: 98ASS23330W		REV: E	
		CASE NUMBER: 987-02		25 MAY 2005	
		STANDARD: JEDEC MS-026 BFA			

4 Revision History

Table 41. Revision History

Revision	Description
2 (Jul 2006)	<ul style="list-style-type: none"> Updated available packages. Inserted mechanical drawings. Corrected signal pinouts and table.
3 (Feb 2007)	<ul style="list-style-type: none"> Changed signal names TIN to DTIN and TOUT to DTOUT to match the MCF52235 ColdFire® Integrated Microcontroller Reference Manual. Added overbars to extend over entire \overline{UCTSn} and \overline{URTSn} signal name. Added revision history. Formatting, layout, spelling, and grammar corrections. Updated block diagram and feature information to match Revision 3 of the MCF52235 ColdFire® Integrated Microcontroller Reference Manual. Deleted the “PSTCLK cycle time” row from the “Debug AC Timing Specifications” table. Added “EPHY Timing” section. Deleted the “RAM standby supply voltage” entry from Table 19. Changed the minimum value for SNR, THD, SFDR, and SINAD in the “ADC parameters” table (was TBD, is “—”). In the “Pin Functions by Primary and Alternate Purpose” table, changed the pin number for $\overline{IRQ11}$ on the 80 LQFP package (was “—”, is 41). Updated the “Thermal characteristics” table to include proper thermal resistance values. Added two tables, “Active Current Consumption Specifications” and “Current Consumption Specifications in Low-Power Modes”, containing the latest current consumption information. Changed the value of T_j in the “Thermal Characteristics” table (was 105 °C, is 130 °C for all packages). Added the following note to and above the “Thermal Characteristics” table: “The use of this device in one- or two-layer board designs is not recommended due to the limited thermal conductance provided by those boards.” Added the value for Ψ_{jt} for the 121MAPBGA package (2.0 °C/W).
4 (May 2007)	<ul style="list-style-type: none"> Formatting, layout, spelling, and grammar corrections. Added load test condition information to the “General Purpose I/O Timing” section. Added specifications for V_{LVD} and V_{LVDHYS} to the “DC electrical specifications” table.
5 (Sep 2007)	<ul style="list-style-type: none"> Formatting, layout, spelling, and grammar corrections. Added information about the MCF52232 and MCF52236 devices. Revised the part number table to include full Freescale orderable part numbers. Synchronized the “Pin Functions by Primary and Alternate Purpose” table in the device reference manual and data sheet. Added specifications for V_{REFL}, V_{REFH}, and V_{DDA} to the “ADC Parameters” table. Added several EPHY specifications.
6 (Oct 2007)	<ul style="list-style-type: none"> Formatting, layout, spelling, and grammar corrections. Changed the data sheet classification (was “Product Preview”, is “Advance Information”). Added the “EzPort Electrical Specifications” section. Updated the “ESD Protection” section.
7 (Aug 2008)	<ul style="list-style-type: none"> Changed document type from Advance Information to Technical Data. Added supported device list in subtitle. Removed preliminary text from electrical specifications section as device is fully characterized. Corrected I_{VREFH}, $VREFH$ current unit from “m” to “mA” in ADC specification table. Changed V_{OFFSET} from TBD to — in ADC specification table.
8 (Jun 2009)	<ul style="list-style-type: none"> Updated Orderable Part Number Summary table to include MCF52233CAL60A, MCF52235CAL60A, and MCF52236AF50A parts